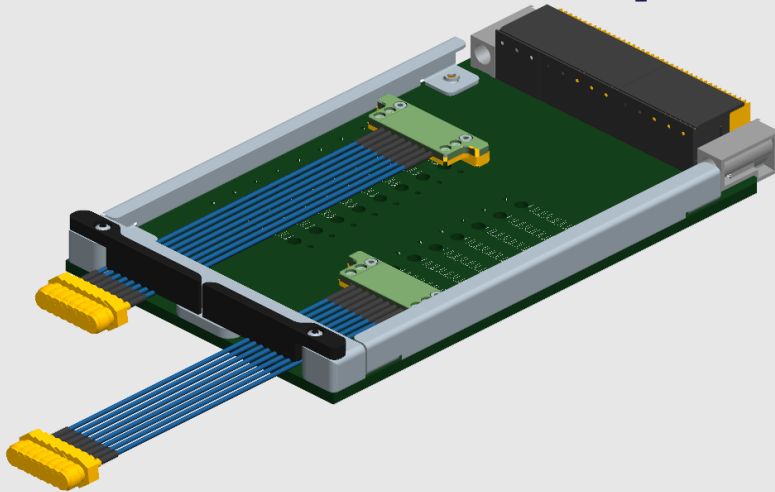


VPX Test Card for High Speed Characterization of Backplane Links

NEW



Features

- Perfectly suited to validate VPX backplane performance in a VPX system
- Excellent signal integrity beyond 26 GHz
- 3U VPX form factor, fits in both conduction and convection cooled slots
- All 68 VPX high speed links available for characterization
- High density compress mount interface to bring high speed links out of the card to external measurement equipment
- Test card including high speed cable adapter fits into a single slot of a VPX backplane with pitch down to 0.8"

Accessories

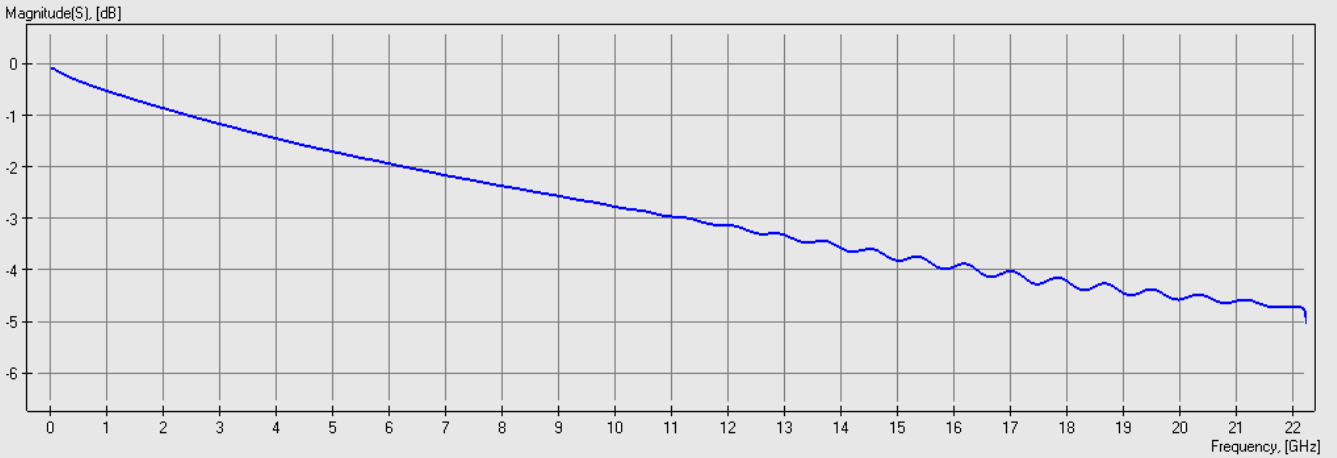
- High Speed Cable Adapter Compress-mount-to-SMA

Benefits

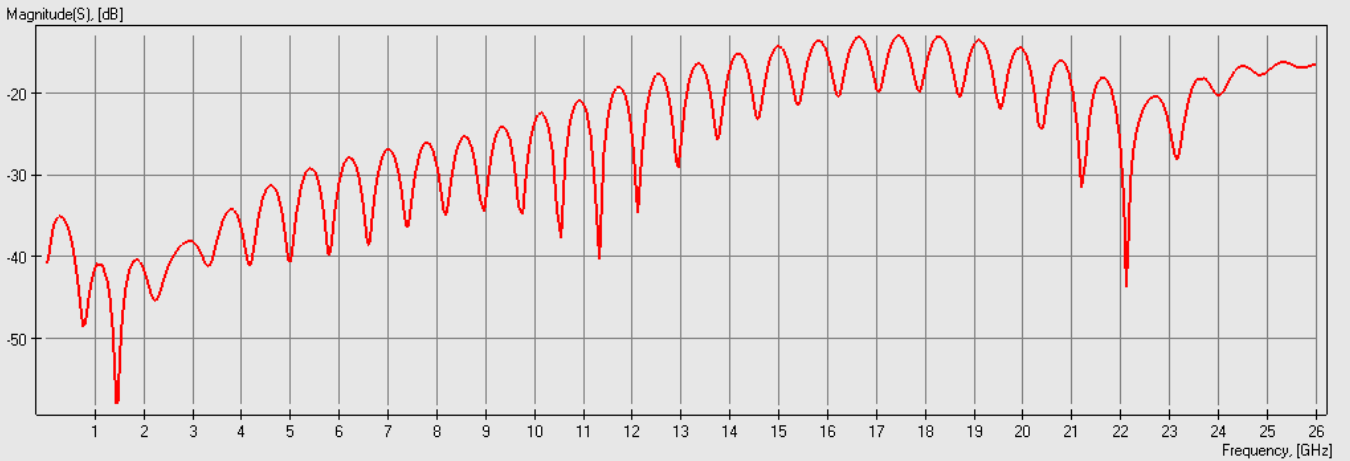
- No need to extract a backplane out of a system to perform links characterization
- Mechanical kit allows for converting between conduction and convection cooled style mechanics
- Every single high speed link on a backplane can be characterized
- Complete S-parameter set as well as crosstalk can be captured with 3 test cards and 4 cable adapters
- Insertion and Return loss are minimized to enable accurate characterization of backplane high speed links

VPX Test Card for High Speed Characterization of Backplane Links

Insertion Loss



Return Loss



High Speed Cable Adapter

